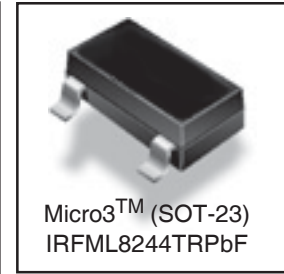
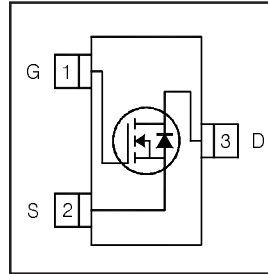


IRFML8244TRPbF

HEXFET® Power MOSFET

V_{DS}	25	V
$V_{GS\ Max}$	± 20	V
$R_{DS(on)\ max}$ (@ $V_{GS} = 10V$)	24	mΩ
$R_{DS(on)\ max}$ (@ $V_{GS} = 4.5V$)	41	mΩ



Application(s)

- Load/ System Switch

Features and Benefits

Features

Low $R_{DS(on)}$ ($\leq 24m\Omega$)
Industry-standard pinout
Compatible with existing Surface Mount Techniques
RoHS compliant containing no lead, no bromide and no halogen
MSL1, Consumer qualification

results in
⇒

Benefits

Lower switching losses
Multi-vendor compatibility
Easier manufacturing
Environmentally friendly
Increased reliability

Absolute Maximum Ratings

Symbol	Parameter	Max.	Units
V_{DS}	Drain-Source Voltage	25	V
$I_D @ T_A = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	5.8	A
$I_D @ T_A = 70^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	4.6	
I_{DM}	Pulsed Drain Current	24	
$P_D @ T_A = 25^\circ C$	Maximum Power Dissipation	1.25	W
$P_D @ T_A = 70^\circ C$	Maximum Power Dissipation	0.80	
	Linear Derating Factor	0.01	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
T_J, T_{STG}	Junction and Storage Temperature Range	-55 to + 150	°C

Thermal Resistance

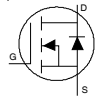
Symbol	Parameter	Typ.	Max.	Units
$R_{\theta JA}$	Junction-to-Ambient ③	—	100	°C/W
$R_{\theta JA}$	Junction-to-Ambient ($t < 10s$) ④	—	99	

IRFML8244TRPbF

Electric Characteristics @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	25	—	—	V	V _{GS} = 0V, I _D = 250μA
ΔV _{(BR)DSS} /ΔT _J	Breakdown Voltage Temp. Coefficient	—	0.02	—	V/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance	—	20	24	mΩ	V _{GS} = 10V, I _D = 5.8A ②
		—	32	41		V _{GS} = 4.5V, I _D = 4.6A ②
V _{GS(th)}	Gate Threshold Voltage	1.35	1.7	2.35	V	V _{DS} = V _{GS} , I _D = 10μA
I _{DSS}	Drain-to-Source Leakage Current	—	—	1.0	μA	V _{DS} = 20V, V _{GS} = 0V
		—	—	150		V _{DS} = 20V, V _{GS} = 0V, T _J = 125°C
I _{GSS}	Gate-to-Source Forward Leakage	—	—	100	nA	V _{GS} = 20V
	Gate-to-Source Reverse Leakage	—	—	-100		V _{GS} = -20V
R _G	Internal Gate Resistance	—	1.6	—	Ω	
g _{fs}	Forward Transconductance	10	—	—	S	V _{DS} = 10V, I _D = 5.8A
Q _g	Total Gate Charge	—	5.4	—	nC	I _D = 5.8A
Q _{gs}	Gate-to-Source Charge	—	1.0	—		V _{DS} = 13V
Q _{gd}	Gate-to-Drain ("Miller") Charge	—	0.81	—		V _{GS} = 10V ②
t _{d(on)}	Turn-On Delay Time	—	2.7	—	ns	V _{DD} = 13V ②
t _r	Rise Time	—	2.1	—		I _D = 1.0A
t _{d(off)}	Turn-Off Delay Time	—	9.0	—		R _G = 6.8Ω
t _f	Fall Time	—	2.9	—		V _{GS} = 10V
C _{iss}	Input Capacitance	—	430	—	pF	V _{GS} = 0V
C _{oss}	Output Capacitance	—	110	—		V _{DS} = 10V
C _{rss}	Reverse Transfer Capacitance	—	49	—		f = 1.0MHz

Source - Drain Ratings and Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
I _S	Continuous Source Current (Body Diode)	—	—	1.25	A	MOSFET symbol showing the integral reverse p-n junction diode. 
I _{SM}	Pulsed Source Current (Body Diode) ①	—	—	24		
V _{SD}	Diode Forward Voltage	—	—	1.2	V	T _J = 25°C, I _S = 5.8A, V _{GS} = 0V ②
t _{rr}	Reverse Recovery Time	—	11	17	ns	T _J = 25°C, V _R = 20V, I _F = 5.8A
Q _{rr}	Reverse Recovery Charge	—	4.2	6.3	nC	di/dt = 100A/μs ②